Silicon P Channel Power MOS FET High Speed Power Switching

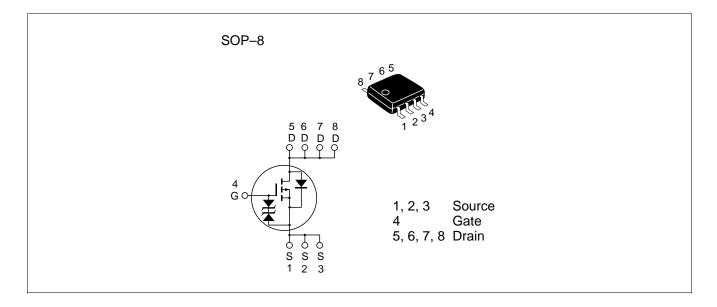
# HITACHI

ADE-208-475 D (Z) 5th. Edition February 1999

#### Features

- Low on-resistance
- Capable of 2.5 V gate drive
- Low drive current
- High density mounting

#### Outline





#### **Absolute Maximum Ratings** (Ta = $25^{\circ}$ C)

Item	Symbol	Ratings	Unit	
Drain to source voltage	V <sub>DSS</sub>	- 20	V	
Gate to source voltage	V <sub>GSS</sub>	± 10	V	
Drain current	I <sub>D</sub>	- 5.5	А	
Drain peak current	Note1 D(pulse)	- 44	А	
Body-drain diode reverse drain current	I <sub>DR</sub>	- 5.5	A	
Channel dissipation	Pch Note2	2.5	W	
Channel temperature	Tch	150	°C	
Storage temperature	Tstg	-55 to +150	°C	

Note: 1. PW  $\leq 10\mu s$ , duty cycle  $\leq 1 \%$ 

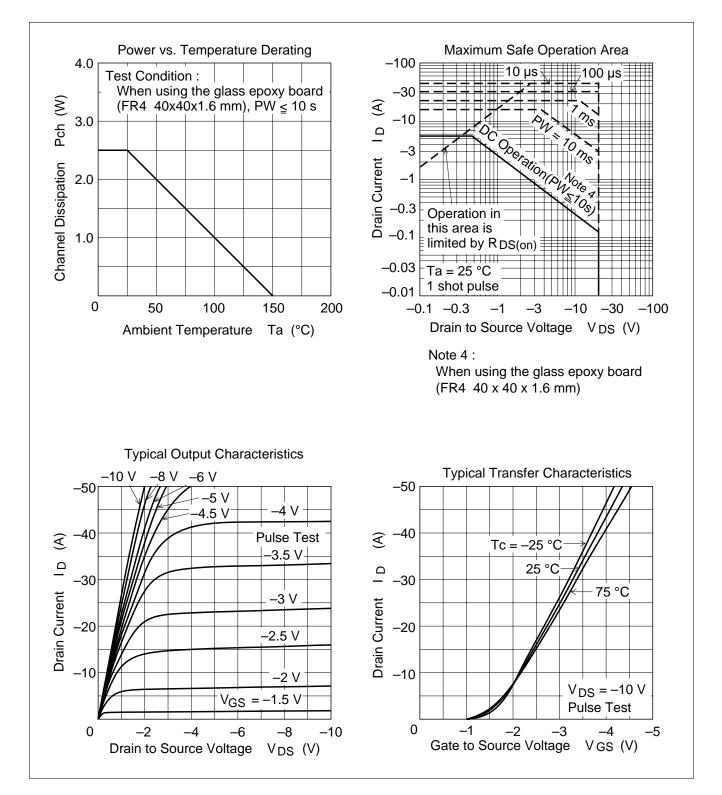
2. When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW $\leq$  10s

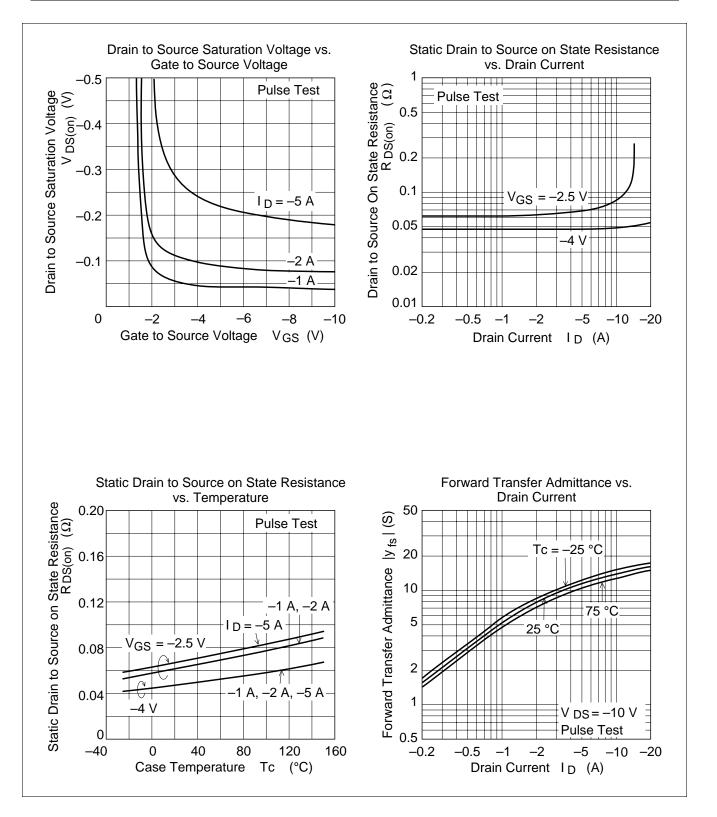
#### **Electrical Characteristics** (Ta = 25°C)

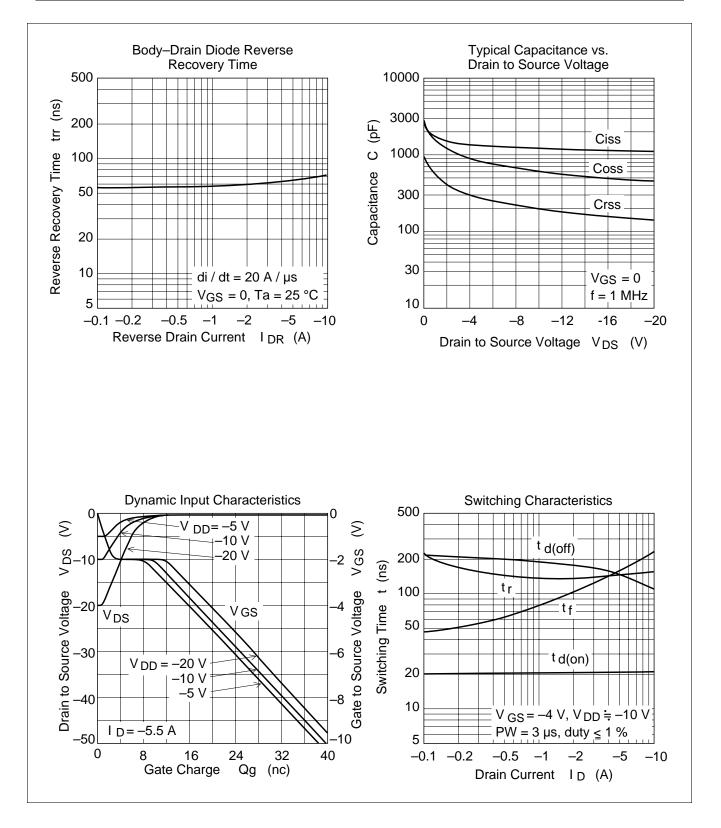
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	- 20	_	—	V	$I_{\rm D} = -10 \text{ mA}, V_{\rm GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	± 10	_	_	V	$I_{\rm G} = \pm 100 \ \mu A, \ V_{\rm DS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	± 10	μΑ	$V_{GS} = \pm 8 V, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>	—	—	- 10	μΑ	$V_{\rm DS} = -20$ V, $V_{\rm GS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	- 0.5	—	- 1.5	V	$V_{\rm DS} = -10 \text{ V}, \text{ I}_{\rm D} = -1 \text{ mA}$
Static drain to source on state	$R_{DS(on)}$	—	0.048	0.060	Ω	$I_{\rm D} = -3$ A, $V_{\rm GS} = -4$ V <sup>Note3</sup>
resistance	$R_{DS(on)}$	—	0.065	0.085	Ω	$I_{\rm D} = -3$ A, $V_{\rm GS} = -2.5$ V <sup>Note3</sup>
Forward transfer admittance	y <sub>fs</sub>	6	9.5	—	S	$I_{\rm D} = -3$ A, $V_{\rm DS} = -10$ V <sup>Note3</sup>
Input capacitance	Ciss		1200	_	pF	V <sub>DS</sub> = - 10 V
Output capacitance	Coss		630		pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	—	200	—	pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>	—	20	—	ns	$V_{GS} = -4 V, I_{D} = -3 A$
Rise time	t,	_	120	_	ns	$V_{DD} \cong -10 \text{ V}$
Turn-off delay time	$t_{d(off)}$		175	_	ns	
Fall time	t <sub>f</sub>	_	140	_	ns	_
Body-drain diode forward voltage	$V_{\text{DF}}$		- 0.9	- 1.4	V	$IF = -5.5 A, V_{GS} = 0^{Note3}$
Body–drain diode reverse recovery time	t <sub>rr</sub>		65		ns	IF = $-5.5$ A, V <sub>GS</sub> = 0 diF/ dt = 20 A/µs

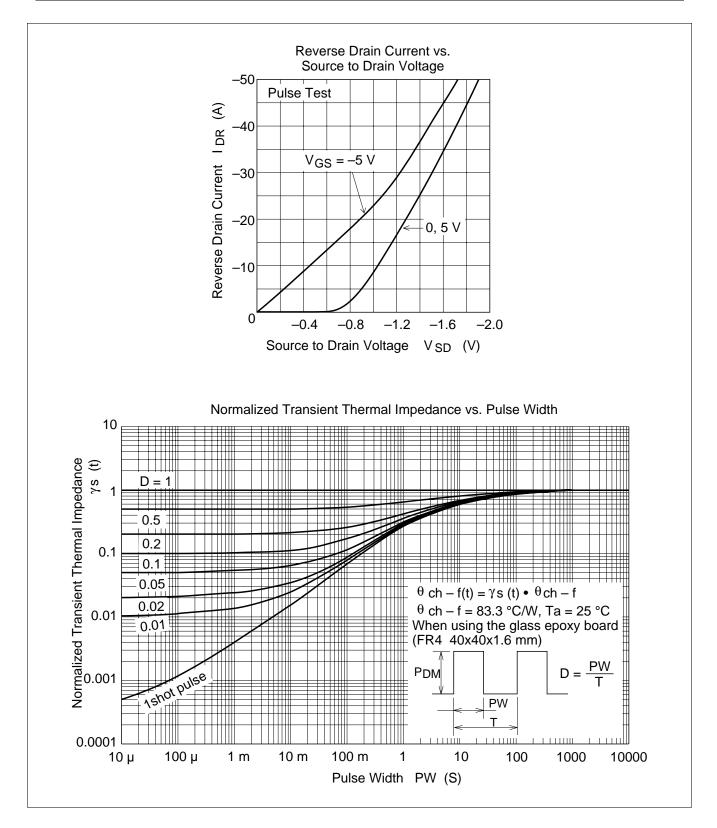
Note: 3. Pulse test

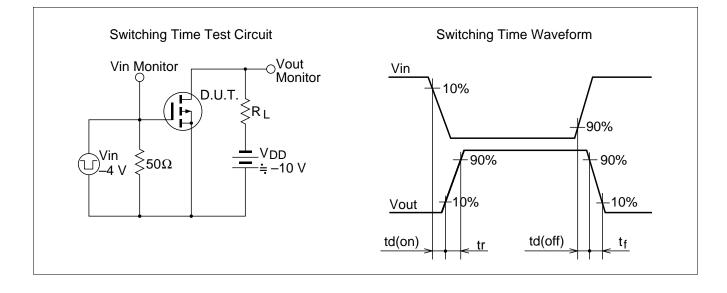
#### **Main Characteristics**





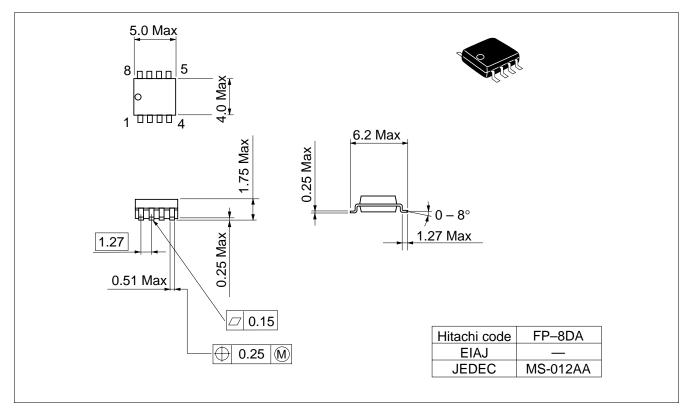






#### **Package Dimensions**

Unit: mm



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